



STK0240

Advanced Power MOSFET

SWITCHING REGULATOR APPLICATIONS

Features

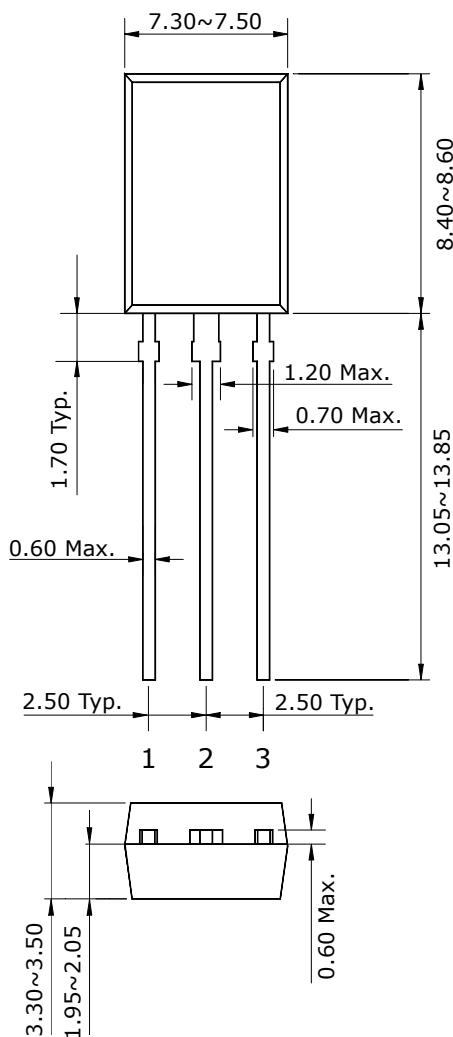
- High Voltage: $BV_{DSS}=400V$ (Min.)
- Low C_{rss} : $C_{rss}=4.9\text{pF}$ (Typ.)
- Low gate charge : $Q_g=4.6\text{nC}$ (Typ.)
- Low $R_{DS(on)}$: $R_{DS(on)}=4.1\Omega$ (Max.)

Ordering Information

Type NO.	Marking	Package Code
STK0240	STK0240	MPT

Outline Dimensions

unit : mm



PIN Connections
 1. Gate
 2. Drain
 3. Source

Absolute maximum ratings

(Ta=25°C)

Characteristic	Symbol	Rating	Unit
Drain-source voltage	V _{DSS}	400	V
Gate-source voltage	V _{GSS}	±30	V
Drain current (DC)	I _D	0.6	A
Drain current (Pulsed) *	I _{DP}	2.4	A
Drain Power dissipation	P _D	1.3	W
Avalanche current (Single) ②	I _{AS}	0.6	A
Single pulsed avalanche energy ②	E _{AS}	4.1	mJ
Avalanche current (Repetitive) ①	I _{AR}	0.6	A
Repetitive avalanche energy ①	E _{AR}	0.1	mJ
Junction temperature	T _J	150	°C
Storage temperature range	T _{stg}	-55~150	

* Limited by maximum junction temperature

Characteristic	Symbol	Typ.	Max	Unit
Thermal resistance	R _{th(J-a)}	-	96.2	°C/W

Electrical Characteristics

(Ta=25°C)

Characteristic	Symbol	Test Condition	Min.	Typ.	Max.	Unit
Drain-source breakdown voltage	BV _{DSS}	I _D =250μA, V _{GS} =0	400	-	-	V
Gate-threshold voltage	V _{GS(th)}	I _D =250μA, V _{DS} = V _{GS}	3.0	-	5.0	V
Drain-source leakage current	I _{DSS}	V _{DS} =400V, V _{GS} =0V	-	-	1	μA
Gate-source leakage	I _{GSS}	V _{DS} =0V, V _{GS} =±30V	-	-	±100	nA
Drain-Source on-resistance ④	R _{DS(ON)}	V _{GS} =10V, I _D =0.3A	-	4.2	5.0	Ω
Forward transfer admittance ④	g _{fs}	V _{DS} =10V, I _D =0.3A	-	1.4	-	S
Input capacitance	C _{iss}	V _{GS} =0V, V _{DS} =25V, f=1MHz	-	127	190	pF
Output capacitance	C _{oss}		-	25	37.5	
Reverse transfer capacitance	C _{rss}		-	4.9	7.4	
Turn-on delay time	t _{d(on)}	V _{DD} =200V, V _{GS} =10V I _D =0.6A, R _G =25Ω ③④	-	8.5	-	ns
Rise time	t _r		-	3.9	-	
Turn-off delay time	t _{d(off)}		-	9	-	
Fall time	t _f		-	3.9	-	
Total gate charge	Q _g	V _{DD} =200V, V _{GS} =10V I _D =0.6A ③④	-	4.6	6.9	nC
Gate-source charge	Q _{gs}		-	1.1	-	
Gate-drain charge	Q _{gd}		-	1.7	-	

Source-Drain Diode Ratings and Characteristics

(Ta=25°C)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Continuous source current	I _S	Integral reverse diode in the MOSFET	-	-	0.6	A
Source current (Pulsed) ①	I _{SM}		-	-	2.4	
Forward voltage ④	V _{SD}	V _{GS} =0V, I _S =0.3A	-	-	1.4	V
Reverse recovery time	t _{rr}	I _s =0.6A, V _{GS} =0V di _s /dt=100A/us	-	180	-	ns
Reverse recovery charge	Q _{rr}		-	0.64	-	uC

Note :

- ① Repetitive Rating : Pulse Width Limited by Maximum Junction Temperature
- ② L=20mH, I_{AS}=0.6A, V_{DD}=50V, R_G=25Ω
- ③ Pulse Test : Pulse Width < 300us, Duty cycle≤ 2%
- ④ Essentially independent of operating temperature

Electrical Characteristic Curves

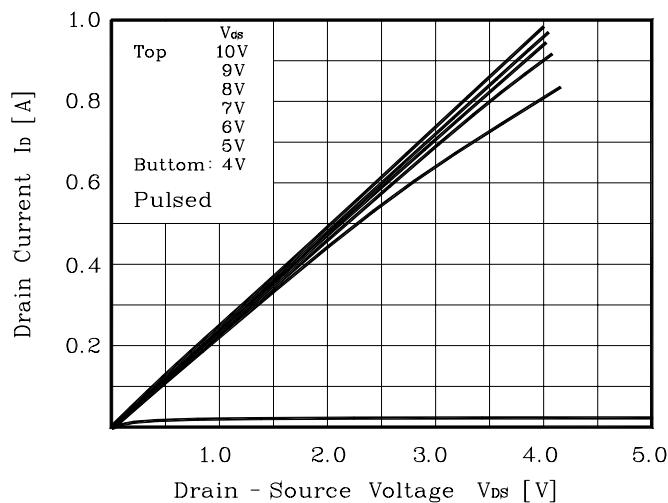
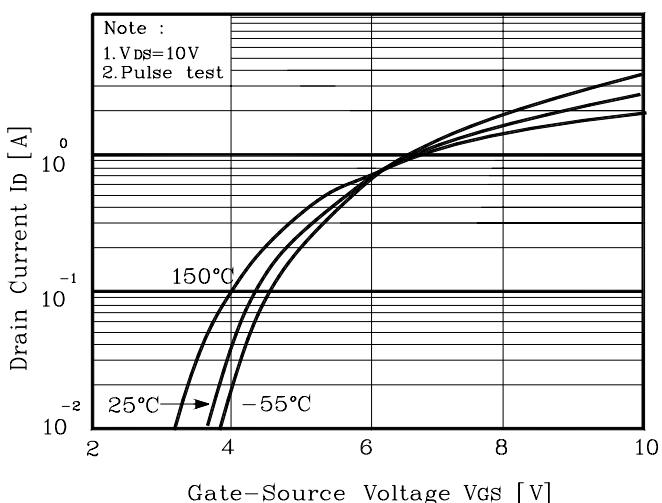
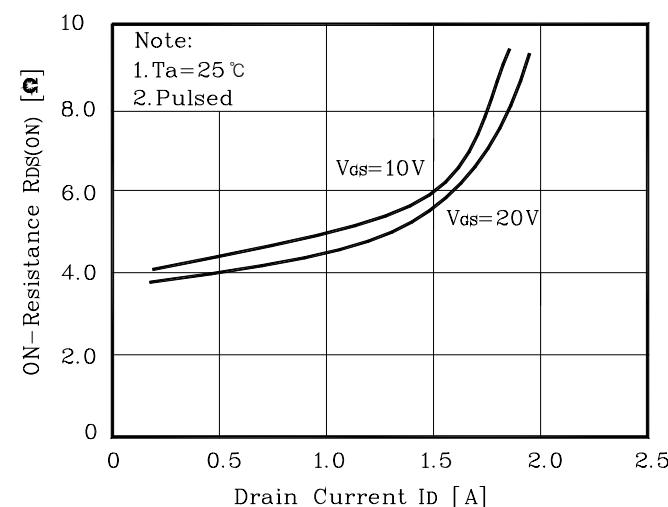
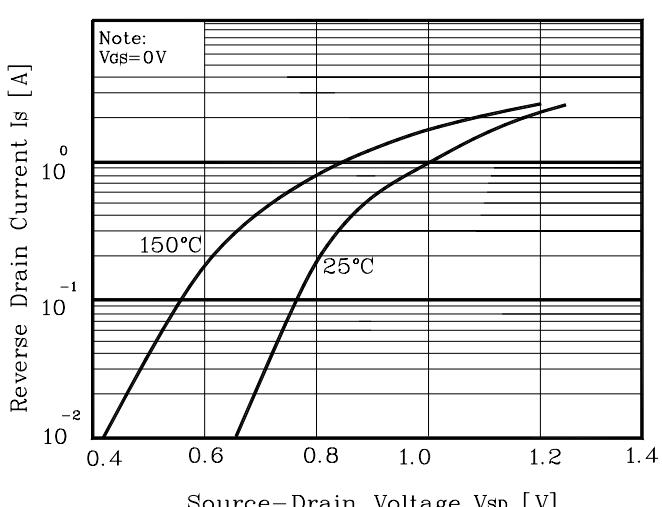
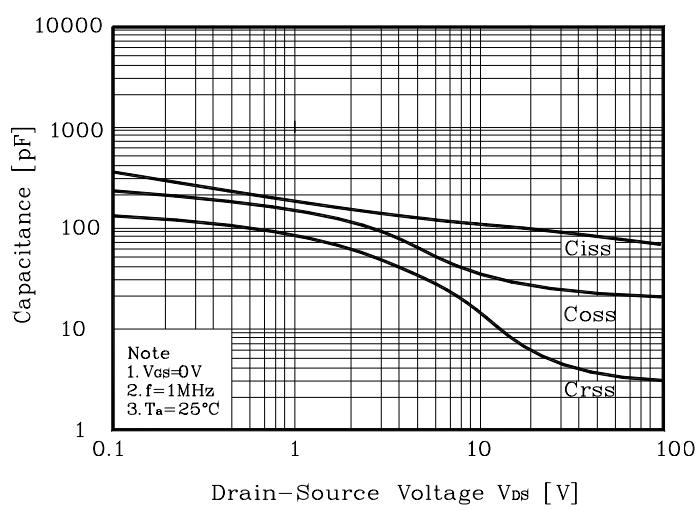
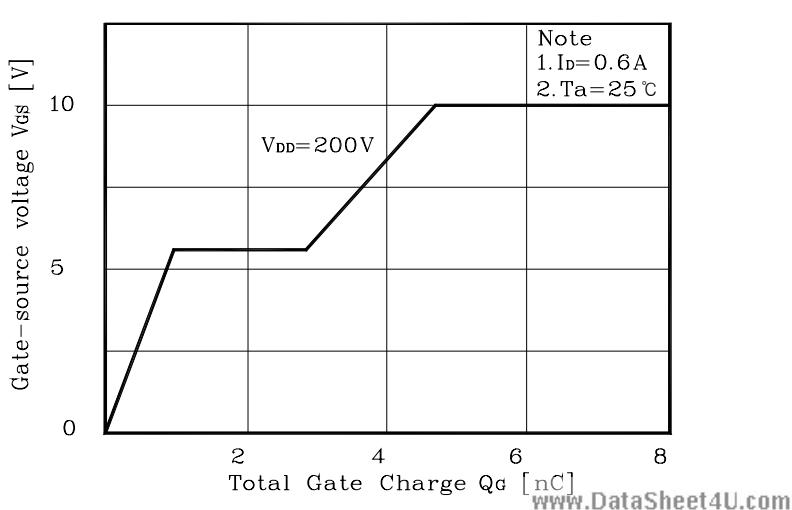
Fig. 1 I_D - V_{DS} **Fig. 2 I_D - V_{GS}** **Fig. 3 $R_{DS(on)}$ - I_D** **Fig. 4 I_S - V_{SD}** **Fig. 5 Capacitance - V_{DS}** **Fig. 6 V_{GS} - Q_G** 

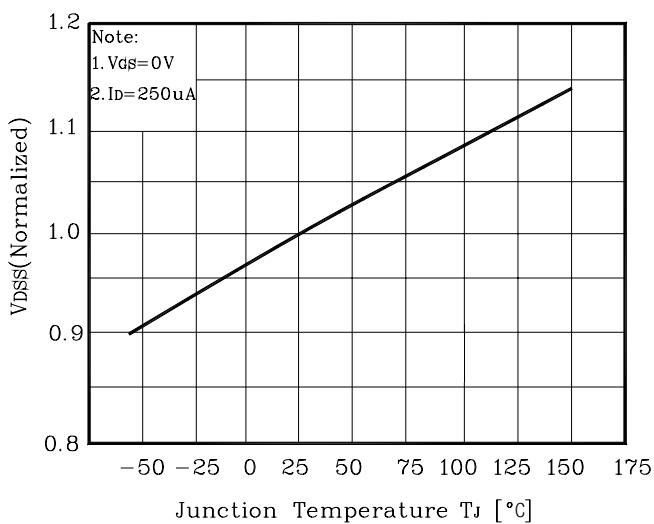
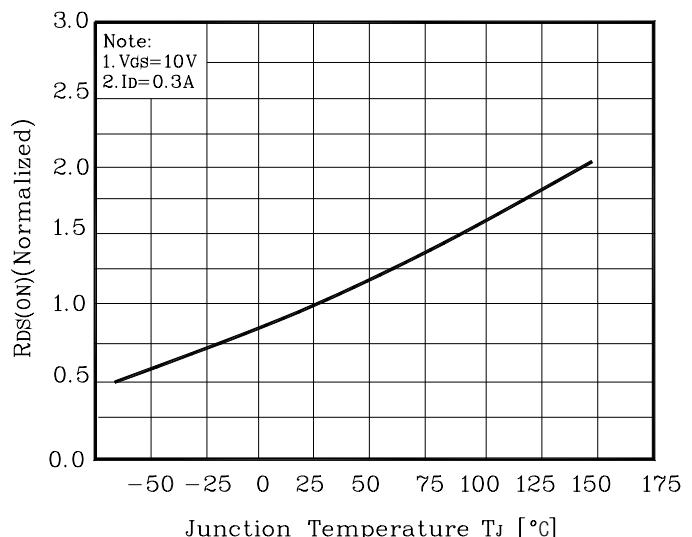
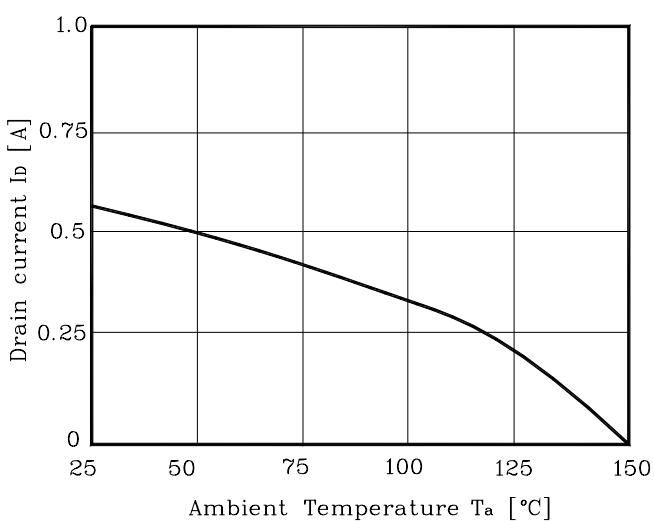
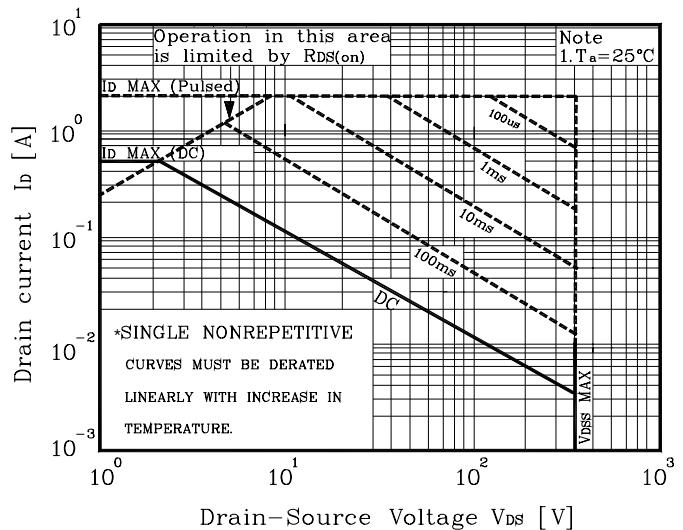
Fig. 7 V_{DSS} - T_J**Fig. 8 R_{DSON} - T_J****Fig. 9 I_D - T_C****Fig. 10 Safe Operating Area**

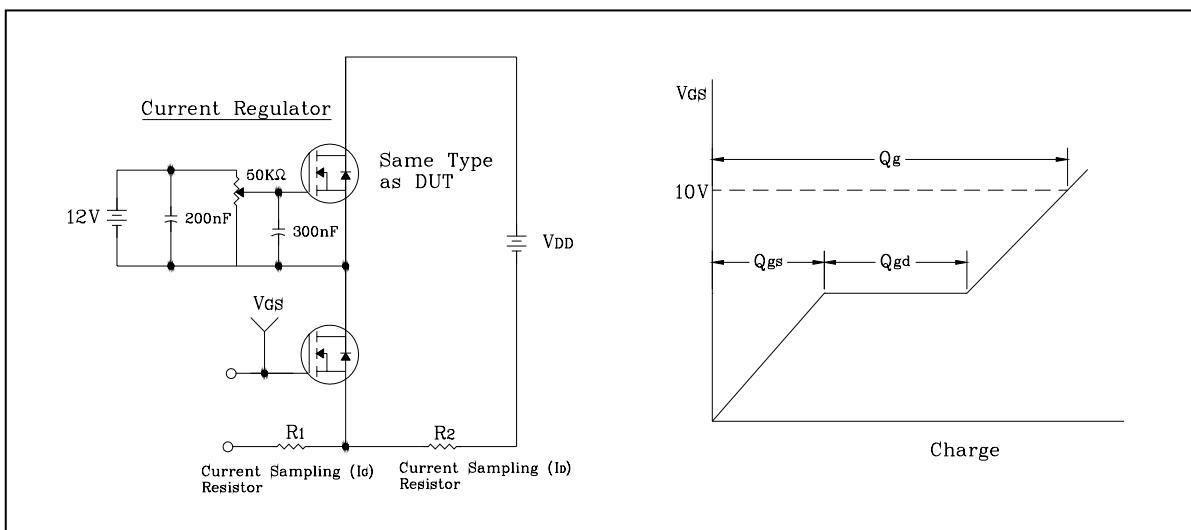
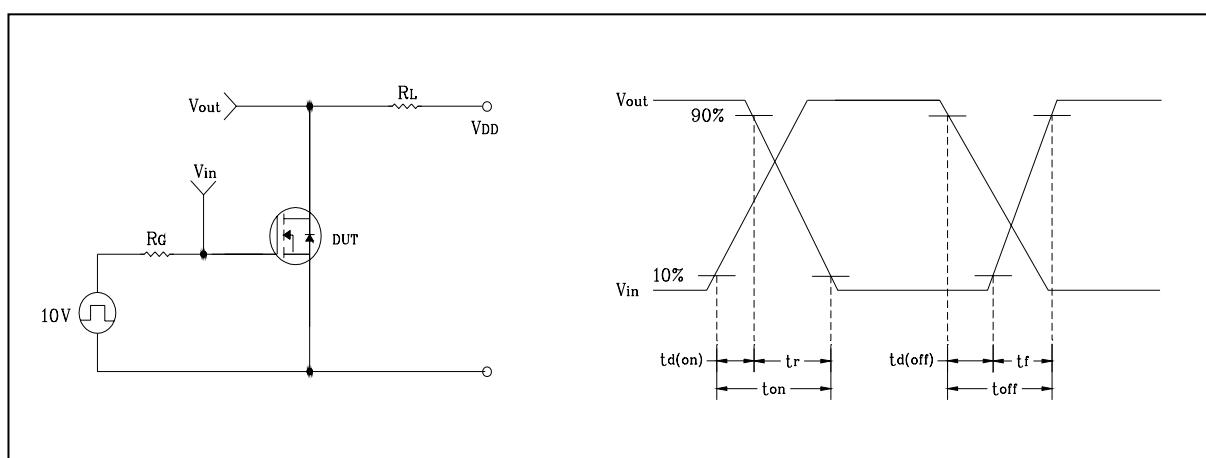
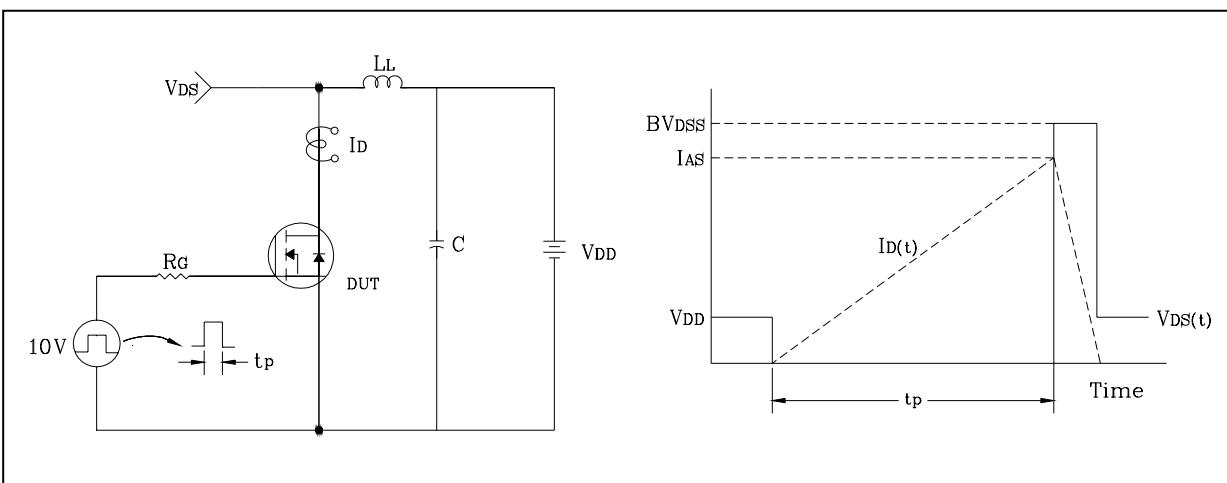
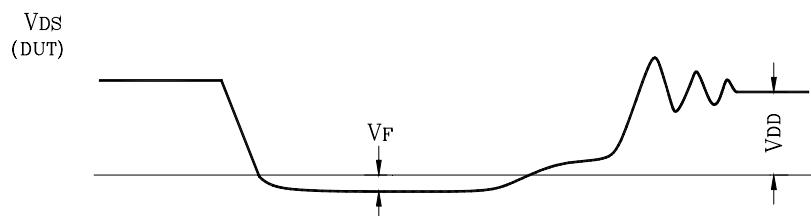
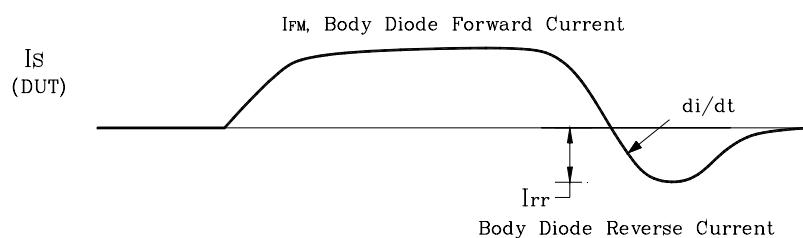
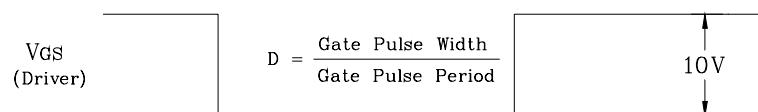
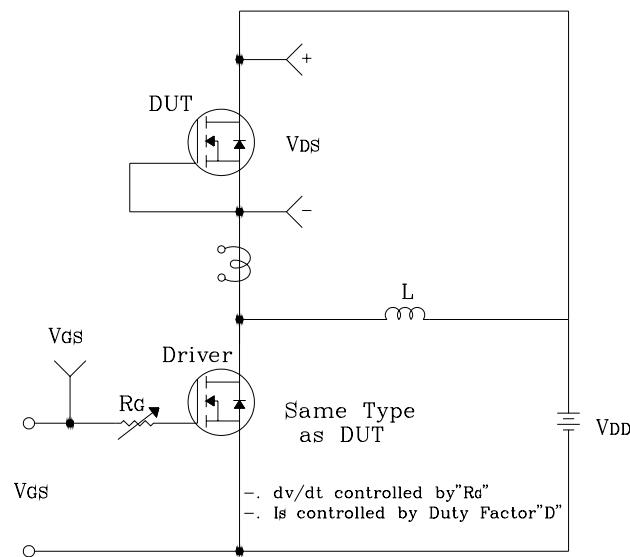
Fig. 11 Gate Charge Test Circuit & Waveform**Fig. 12 Resistive Switching Test Circuit & Waveform****Fig. 13 E_{AS} Test Circuit & Waveform**

Fig. 14 Diode Reverse Recovery Time Test Circuit & Waveform

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